RoHS

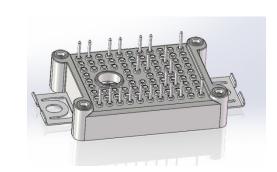


JLPI15B120RE1E6SN

LE1 PACK module with Trench/Fieldstop IGBT and Emitter Controlled diode and NTC

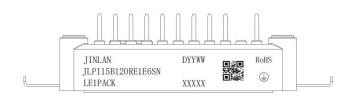
Features

- Low V_{CE(sat)} Trench IGBT technology
- 10 µ s short circuit capability
- V_{CE(sat)} with positive temperature coefficient
- Maximum junction temperature 175°C
- Low inductance case
- Al₂O₃ substrate with low thermal resistance
- Solder Contact Technology
- · Rugged mounting due to integrated mounting clamps



LE1 Pack

MARKING DIAGRAM



Typical Applications

- · Inverter for motor drive
- · AC and DC servo drive amplifier
- Uninterruptible power supply

JINLAN

= Company Name

JLPI15B120RE1E6SN

= Specific Device Code

YYWW

= Year and Work Week Code

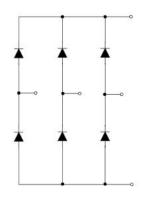
XXXXX

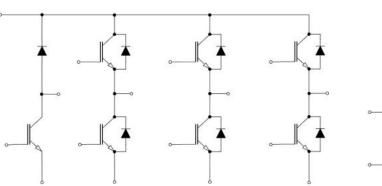
= Serial Number

QR code

= Custom Assembly Information

Description







Package Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V _{ISOL}	RMS,f=50Hz,t=60s	2.5	kV
Internal isolation		basic insulation(class 1,IEC 61140)	Al ₂ O ₃	
Creepage distance	d _{creep}	terminal to heatsink	11.5	mm
Creepage distance	d _{creep}	terminal to terminal	6.3	mm
Clearance	d _{clear}	terminal to heatsink	10	mm
Clearance	d _{clear}	terminal to terminal	5	mm
Comparative tracking index (electrical)	СТІ		>200	
RTI Elec.	RTI	housing	140	°C

Package Characteristic values

_			Values			
Parameter	Symbol	Note or test condition	Min.	Тур.	Max.	Unit
Stray Inductance	LCE			30		nH
Storage Temperature Range	T _{STG}		-40		125	$^{\circ}$
Mountig force per clamp	F		20		50	N
Weight	G			24		g



IGBT, Inverter

Absolute Maximum Ratings (Tc = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
Vces	Collector-Emitter Voltage 1200		V
V _{GES}	Gate-Emitter Voltage ±25		V
Ic	Collector Current @ T _C =25 ℃	30	Α
	Collector Current @ T_C =100 $^{\circ}$ C	15	Α
I _{CM}	Pulsed Collector Current, t_p limited by T_{v_jmax}	30	Α

Characteristics (Tc = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
.,		V _{GE} = 15 V, I _C = 15 A, T _{vj} = 25°C		1.55	1.90	.,
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 15 A, T _{vj} = 150°C		1.70		\ \ \
V _{GE(TH)}	Gate-Emitter Threshold Voltage	$V_{GE} = V_{CE}$, $IC = 1mA, T_{vj} = 25$ °C	5.0	6.0	7.0	V
I _{CES}	Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} =V _{CES} ,T _{vj} = 25°C	-		100	μA
I _{GES}	Gate-Emitter Leakage Current	$V_{GE} = V_{GES}$, $V_{CE} = 0$ V, $T_{vj} = 25$ °C			200	nA
RGint	Internal Gate Resistance	f=1MHz	-	0.5		Ω
Cies	Input Capacitance	V _{CE} =30V,f=1MHz,		1430		рF
C _{oes}	Output Capacitance	V _{GE} =0V	-	35		рF
Cres	Reverse Transfer Capacitance		-	25		рF
Q_G	Gate Charge	V _{CC} =960V,V _{GE} = 15V, I _C =15A	1	90		nC
td(on)	Turn-On Delay Time			23		
tr	Rise Time			21		ns
td(off)	Turn−off Delay Time	VCC = 600 V, IC = 15 A RGon = 25Ω,RGoff =25Ω		206		115
tf	Fall Time	VGE =±15V		22		
Eon	Turn-On Switching Loss per Pulse	Inductive Load T _{vj} = 25°C		0.9		
Eoff	Turn Off Switching Loss per Pulse			0.6		mJ
E _{ts}	Total Switching Loss			1.5		
td(on)	Turn-On Delay Time			TBD		
tr	Rise Time			TBD		
td(off)	Turn−off Delay Time			TBD		ns
tf	Fall Time	$V_{CC} = 600 \text{ V, } I_{C} = 15 \text{ A}$ $R_{Gon} = 25\Omega, R_{Goff} = 25\Omega$	-	TBD		
Eon	Turn-on Switching Loss per Pulse	V _{GE} =±15V	-	TBD		
Eoff	Turn Off Switching Loss per Pulse	T _{vj} = 150°C	-	TBD		mJ
E _{ts}	Total Switching Loss			TBD		
I _{SC}	SC Data	t _P ≤10μs,V _{GE} ≤15V, τ _{vi} =150°C,V _{CC} =600V	-	70		Α
R _{thJC}	Thermal resistance	Junction-to-Case (per IGBT)		1.077		K/W
T _{vj op}		Temperature under switching conditions	-40		175 ¹⁾	$^{\circ}$

¹)T_{vj op} > 150 ℃ is only allowed for operation at overload conditions.



Diode, Inverter

Absolute Maximum Ratings (Tc = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
V _{RRM}	Repetitive Peak Reverse Voltage	1200	V
I _F	Diode Continuous Forward Current	15	Α
I _{FM}	Diode Maximum Forward Current t _p =1ms	30	Α

Characteristics (Tc=25℃ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
	_, , , , , , , , , , , , , , , , ,	$I_F = 15A, V_{GE} = 0V, T_{vj} = 25^{\circ}C$	1	2.2	3.0	.,
V _F	Diode Forward Voltage	I _F = 15A, V _{GE} =0V, T _{vj} = 150°C		2.0		V
Qr	Recovered Charge	V _{CC} = 600 V, I _C = 15 A		0.72		μC
I _{RM}	Peak Reverse Recovery Current	$R_{Gon} = 25\Omega, R_{Goff} = 25\Omega$ $V_{GF} = \pm 15V$		12		Α
Trr	Reverse Recovery Time	Inductive Load T _{vj} = 25°C		120		ns
Qr	Recovered Charge	V _{CC} = 600 V, I _C = 15 A		TBD		μC
I _{RM}	Peak Reverse Recovery Current	$R_{Gon} = 25\Omega, R_{Goff} = 25\Omega$ $V_{GF} = \pm 15V$		TBD		Α
T _{rr}	Reverse Recovery Time	Inductive Load T _{vj} = 150°C		TBD		ns
R _{thJC}	Thermal resistance	Junction-to-Case (per diode)		1.648		K/W
T _{vj op}		Temperature under switching conditions	-40		175 ²⁾	$^{\circ}$

 $^{^{2)}}T_{\nu j\,op}$ > 150 $^{\circ}{\rm C}$ is only allowed for operation at overload conditions.

Diode, Rectifier

Absolute Maximum Ratings (Tc = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1600	V
I _F	Diode Continuous Forward Current	15	Α
I _{FM}	Diode Maximum Forward Current t _p =1ms	30	Α

Characteristics (Tc=25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
V _F	Diode Forward Voltage	I _F =15A, T _{vj} = 150 °C	-	1.2	-	V
I _R	Reverse Current	T _{vj} =150 °C, V _R =1600V	-	1.0	1	mA
R _{thJC}	Thermal resistance	Junction-to-Case (per diode)		0.930		K/W
T _{vj op}		Temperature under switching conditions	-40	·	175 ³⁾	$^{\circ}$

 $^{^{3)}}T_{\nu j\,op}$ > 150 $^{\circ}{\rm C}$ is only allowed for operation at overload conditions.



IGBT, Chopper

Absolute Maximum Ratings (Tc = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
V _{CES}	Collector-Emitter Voltage 1200		V
V_{GES}	Gate-Emitter Voltage ±30		V
	Collector Current @ T _C =25 ℃	30	Α
l lc	Collector Current @ T _C =80 ℃	15	Α
I _{CM}	Pulsed Collector Current, t _p =1S	30	Α

Characteristics (Tc = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
	0 11 1 5 11 0 1 11 11 11	V _{GE} = 15 V, I _C = 15 A, T _{vj} = 25°C		1.55	1.90	.,
$V_{\text{CE(sat)}}$	Collector-Emitter Saturation Voltage	V _{GE} = 15 V, I _C = 15 A, T _{vj} = 150°C		1.70		V
V _{GE(TH)}	Gate-Emitter Threshold Voltage	V _{GE} = V _{CE} , IC = 1mA,T _{vj} = 25°C	5.0	6.0	7.0	V
Ices	Collector-Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} =V _{CES} ,T _{vj} = 25°C			100	μA
I _{GES}	Gate-Emitter Leakage Current	$V_{GE} = V_{GES}$, $V_{CE} = 0$ V, $T_{vj} = 25$ °C			200	nA
RGint	Internal Gate Resistance	f=1MHz	-	0.5		Ω
C _{ies}	Input Capacitance	V _{CE} =30V,f=1MHz,		1430		рF
Coes	Output Capacitance	V _{GE} =0V	-	35		рF
C _{res}	Reverse Transfer Capacitance			25		рF
Q _G	Gate Charge	V _{CC} =960V,V _{GE} = 15V, I _C =15A		90		nC
td(on)	Turn-On Delay Time			23		
tr	Rise Time			21		ns
td(off)	Turn−off Delay Time	VCC = 600 V, IC = 15 A RGon = 25Ω,RGoff =25Ω VGE =±15V Inductive Load T_{v_j} = 25°C		206		115
tf	Fall Time			22		
Eon	Turn-On Switching Loss per Pulse			0.9		
Eoff	Turn Off Switching Loss per Pulse		-	0.6		mJ
E _{ts}	Total Switching Loss			1.5		
td(on)	Turn-On Delay Time			TBD		
tr	Rise Time			TBD		
td(off)	Turn-off Delay Time			TBD		ns
tf	Fall Time	$V_{CC} = 600 \text{ V}, I_{C} = 15 \text{ A}$ $R_{Gon} = 25\Omega, R_{Goff} = 25\Omega$		TBD		
Eon	Turn-on Switching Loss per Pulse	V _{GE} =±15V		TBD		
Eoff	Turn Off Switching Loss per Pulse	T _v j = 150°C		TBD		mJ
E _{ts}	Total Switching Loss			TBD		
Isc	SC Data	t _P ≤10μs,V _{GE} ≤15V, τ _{vi} =150℃,V _{CC} =600V	-	70		А
R _{thJC}	Thermal resistance	Junction-to-Case (per IGBT)		1.019		K/W
T _{vj op}		Temperature under switching conditions	-40		175 ¹⁾	$^{\circ}$
	1	1				



Diode, Chopper

Absolute Maximum Ratings (Tc = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
V _{RRM}	Repetitive Peak Reverse Voltage	1200	V
I _F	Diode Continuous Forward Current	10	Α
I _{FM}	Diode Maximum Forward Current t _p =1ms	20	Α

Characteristics (Tc=25°C unless otherwise noted)

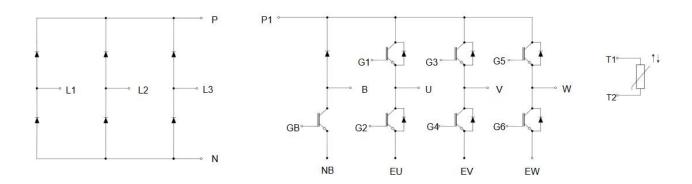
	Stres (1c-25 Curiless otherwise noted)					
.,	Die de Fernand Vellere	$I_F = 10A, V_{GE} = 0V, T_{vj} = 25^{\circ}C$		1.60		.,
V _F	Diode Forward Voltage	I _F =10A, V _{GE} =0V, T _{vj} = 150°C		1.50		V
Qr	Recovered Charge	V _R =600V.I _F =10A.	-	0.214		μC
I _{RM}	Peak Reverse Recovery Current	$R_{Gon} = 10\Omega, R_{Goff} = 25\Omega$ $V_{GE} = \pm 15V.$		5.22		Α
Trr	Reverse Recovery Time	VGE -113V, T _{vj} =25℃	-	27.5		ns
E _{rec}	Reverse Recovery Energy			0.090		mJ
Qr	Recovered Charge	V 999VI 494	-	0.495		μC
I _{RM}	Peak Reverse Recovery Current	$V_R=600V,I_F=10A,$ $R_{Gon}=10\Omega,R_{Goff}=25\Omega$	-	7.97	-	Α
Trr	Reverse Recovery Time	V _{GE} =±15V, T _{vi} =150℃		42.9	-	ns
E _{rec}	Reverse Recovery Energy	. vj - 1 33 3	1	0.291		mJ
R _{thJC}	Thermal resistance	Junction-to-Case (per diode)		1.862		K/W
T _{vj op}		Temperature under switching conditions	-40		175 ²⁾	$^{\circ}$ C

NTC Characteristics (Tc = 25°C unless otherwise noted)

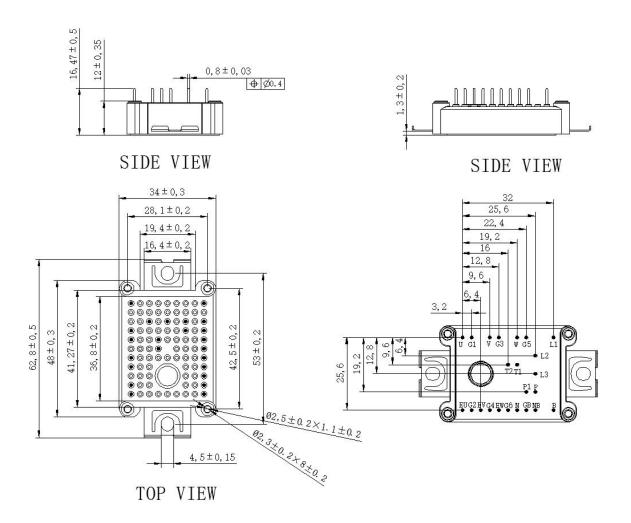
Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
R ₂₅	Rated Resistance			5.0		kΩ
ΔR/R	Deviation of R ₁₀₀	T _C =100 °C,R ₁₀₀ =493.3 Ω	-5		5	%
P ₂₅	Power Dissipation				20.0	mW
B _{25/50}	B-value	R ₂ =R ₂₅ exp[B _{25/50} (1/T ₂ - 1/(298.15K))]		3375		К
B _{25/80}	B-value	R ₂ =R ₂₅ exp[B _{25/80} (1/T ₂ - 1/(298.15K))]		3411		K
B _{25/100}	B-value	R ₂ =R ₂₅ exp[B _{25/100} (1/T ₂ - 1/(298.15K))]		3433		K



CIRCUIT DIAGRAM



PACKAGE DIMENSION





REVISION HISTORY

Document version	Date of release	Description of changes
Rev.00	2025-05-30	Preview



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